

# Industrial Embedded Systems - Design for Harsh Environment -

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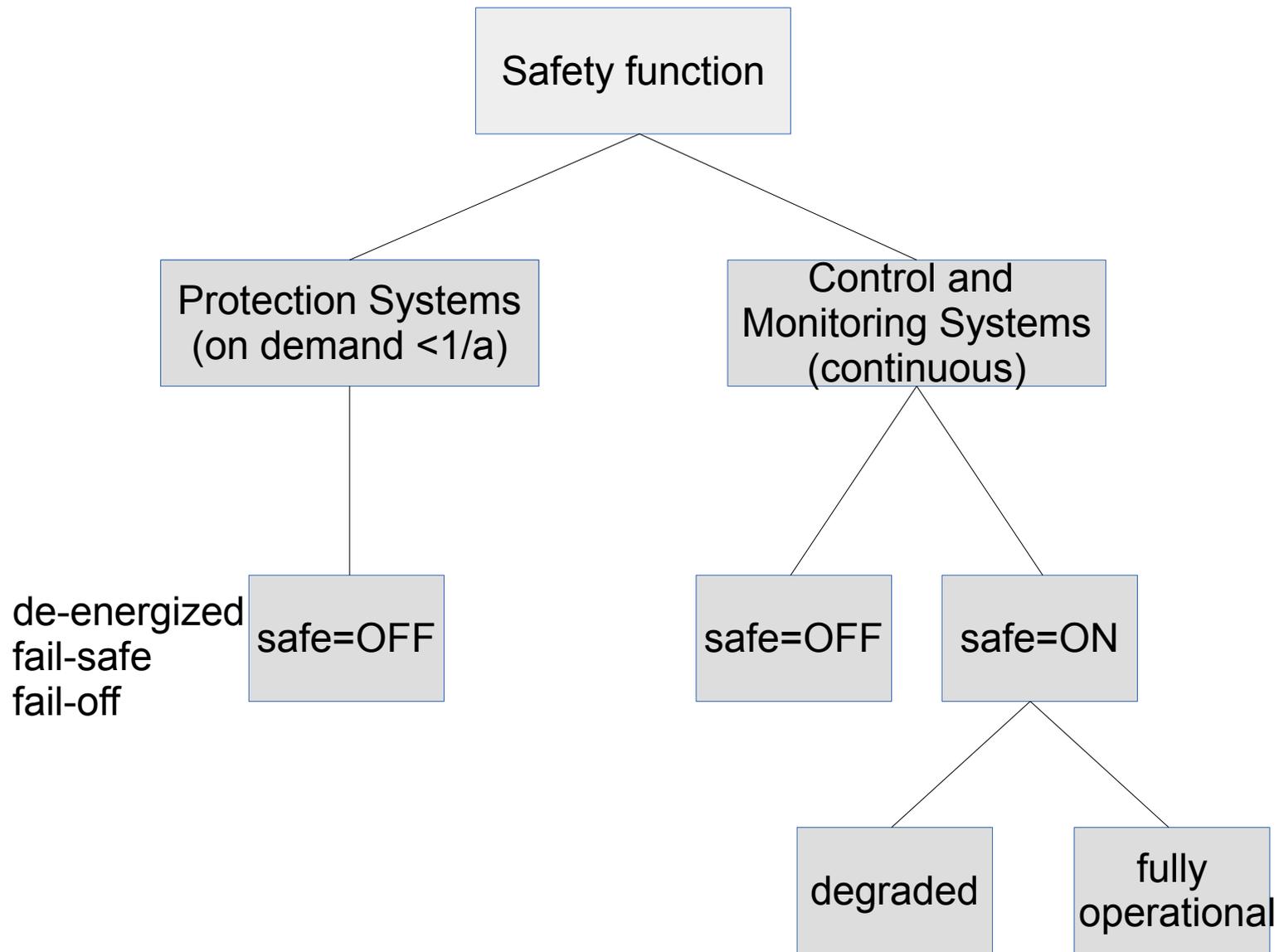
IN2244

Part VI – Safety Architectures

WS 2015/16

Technische Universität München

# Fail-safe and Fail-operational Systems



# Architecture Constraints

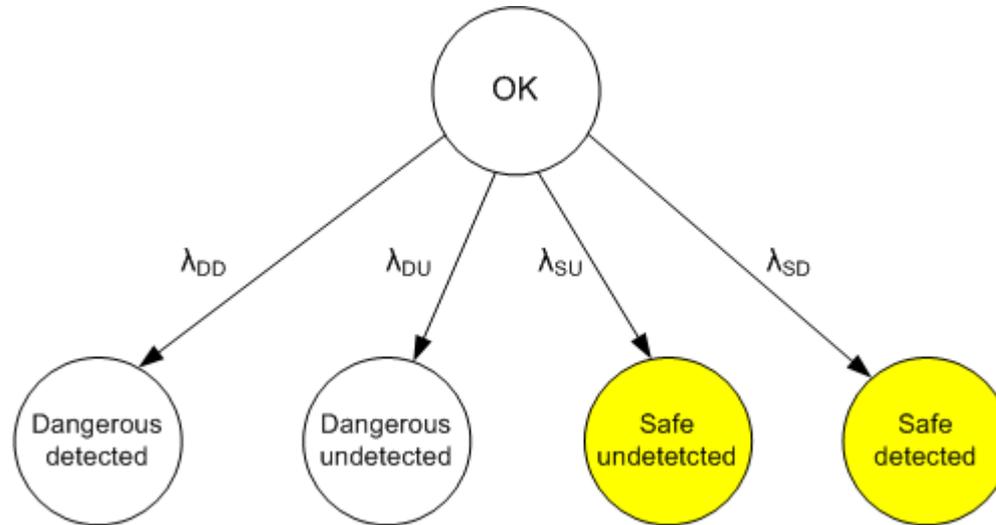
Safe failure fraction	Hardware fault tolerance (see note 2)		
	0	1	2
< 60 %	Not allowed	SIL1	SIL2
60 % – < 90 %	SIL1	SIL2	SIL3
90 % – < 99 %	SIL2	SIL3	SIL4
≥ 99 %	SIL3	SIL4	SIL4

NOTE 1 See 7.4.3.1.1 to 7.4.3.1.4 for details on interpreting this table.  
 NOTE 2 A hardware fault tolerance of N means that N + 1 faults could cause a loss of the safety function.  
 NOTE 3 See annex C for details of how to calculate safe failure fraction.

Source:  
IEC61508

- Besides providing a specific quality (failure rate) a safety function must be hosted by a specific architecture in context of IEC 61508
- Besides architecture constraints also specific fault detection mechanisms must be realized by the final design. This is expressed by the safe failure fraction (SFF)

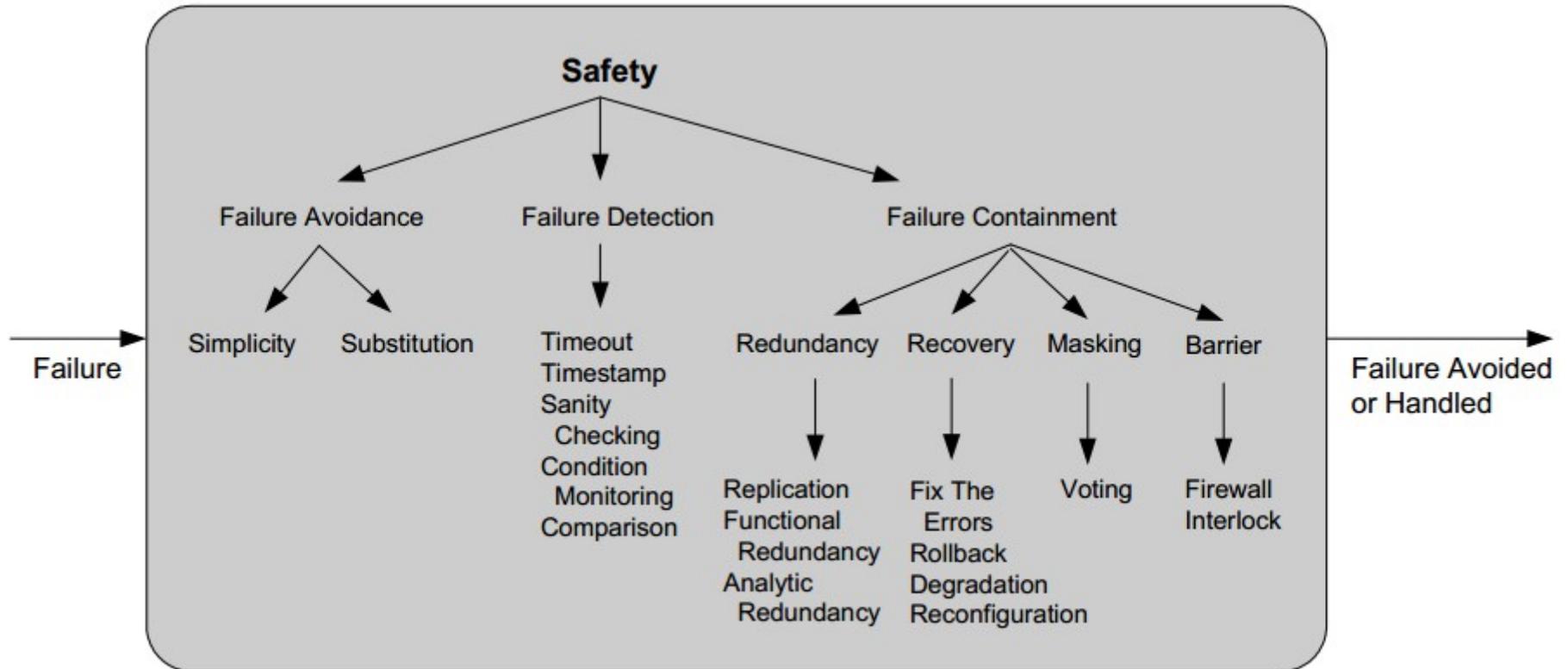
# Safe Failure Fraction (SFF)



- Failure (this is the same failure rate as in the reliability lecture) can happen in a safe or dangerous way.

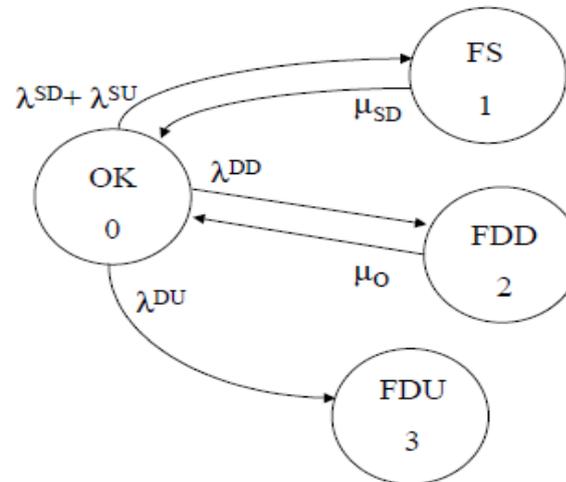
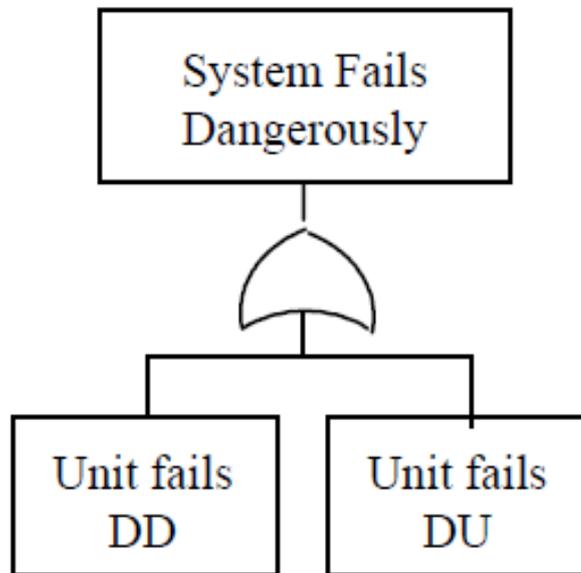
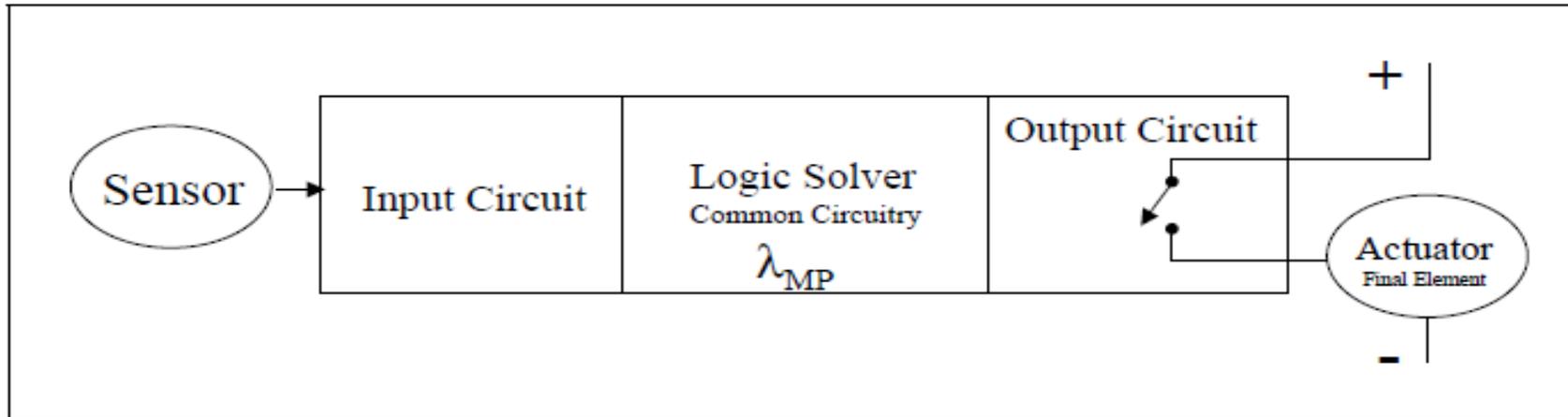
- $$SFF = 1 - \frac{\lambda_{du}}{\lambda_{total}}; \lambda_{total} = \lambda_{du} + \lambda_{dd} + \lambda_{su} + \lambda_{sd}$$

# Failure Mitigation



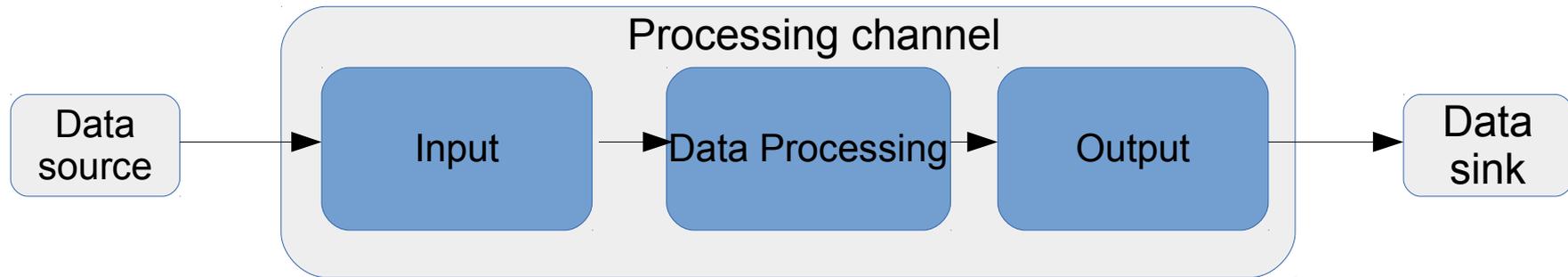
Source:  
Wu, Kelly: Safety Tactics for  
Software Architecture  
Design

# One Channel - 1oo1 System



Source:  
Goble, Safety instrumented systems verification:  
practical probabilistic calculation

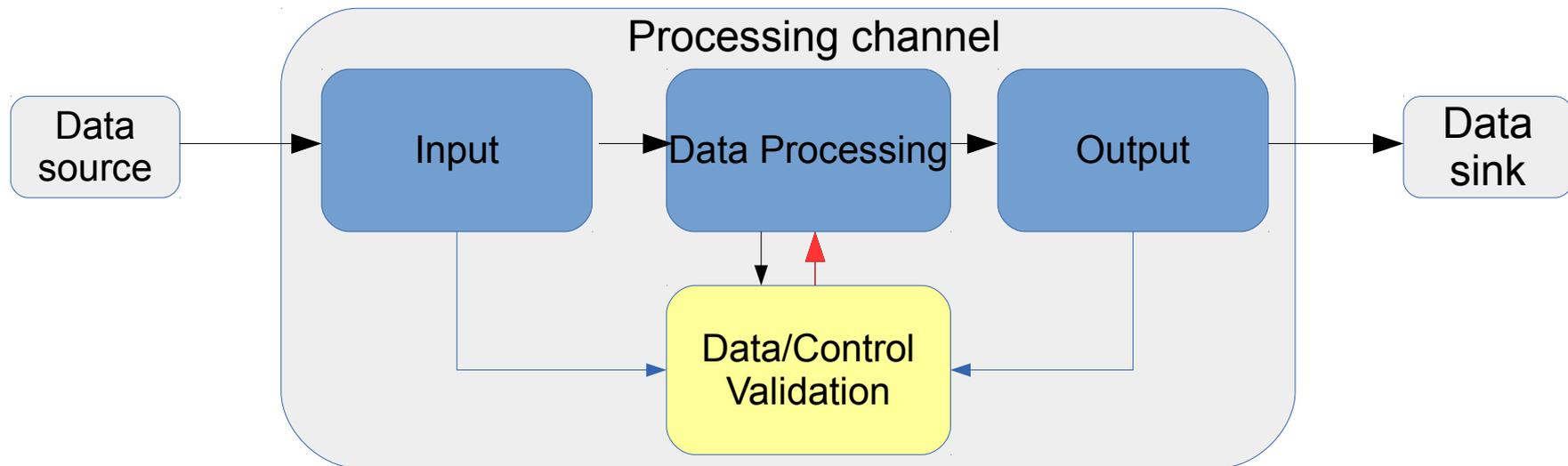
# 1001 - Basic -



- Reliability (random faults): see previous calculations
- Reliability (systematic faults): highly affected
- Safety: 1001 architecture, not used

# 1001

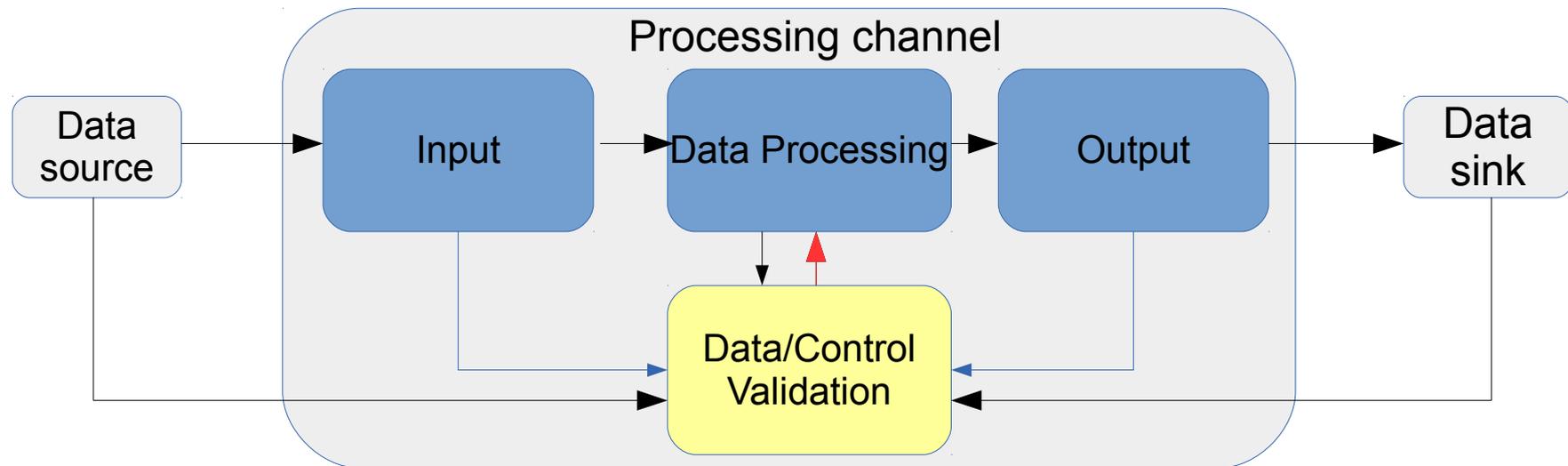
## - self-monitoring -



- Provides data and control flow checks (sanity checks)
  - Internal watchdog, acceptance tests by limits, etc.
- Use: not used in safety-related applications, reliability increase (depends on application)

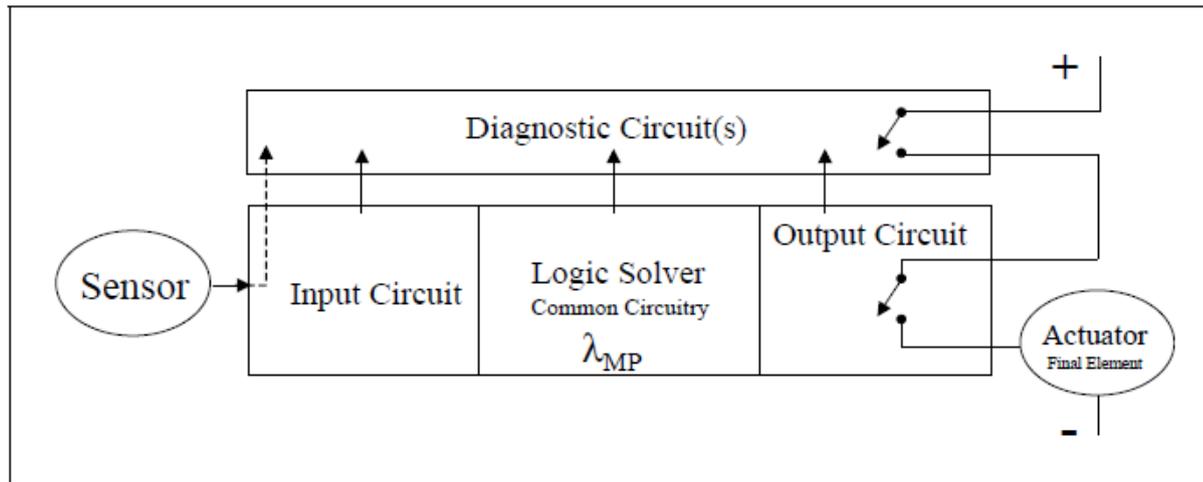
# 1001

## - condition-monitoring -

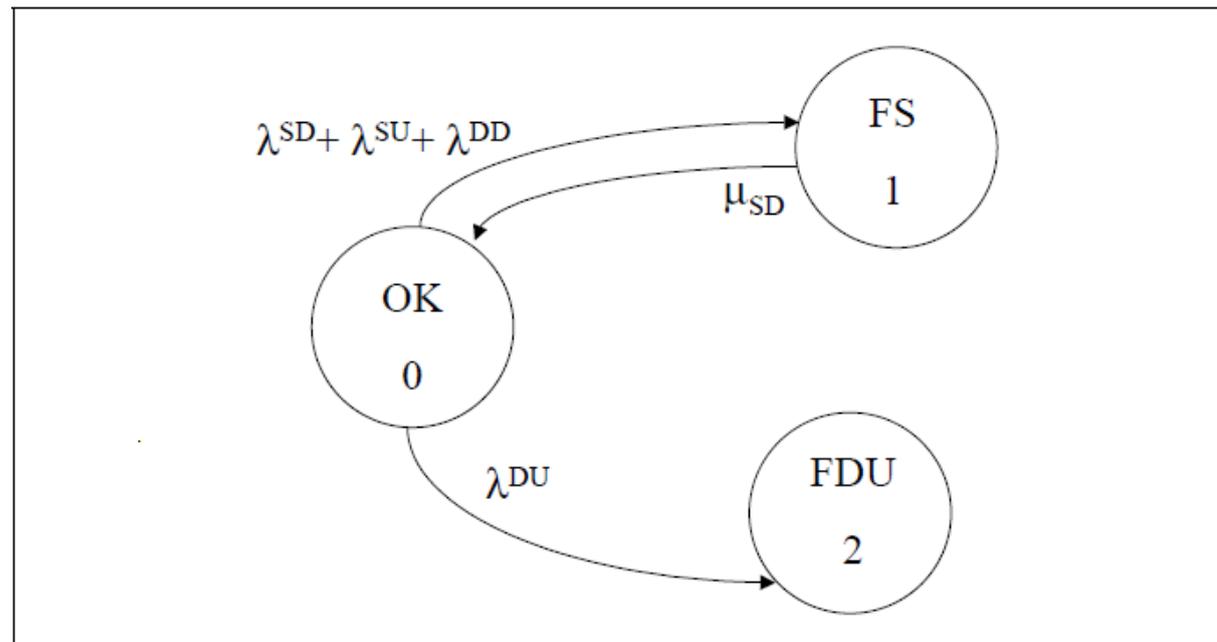
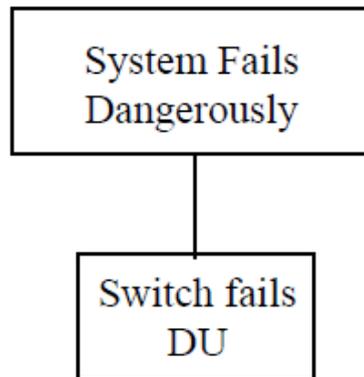


- Provides additional checks on input and/or output
- Use: not used in safety-related applications, reliability increase (depends on application)
- More expensive since additional hardware needed

# One Channel - 1oo1D System

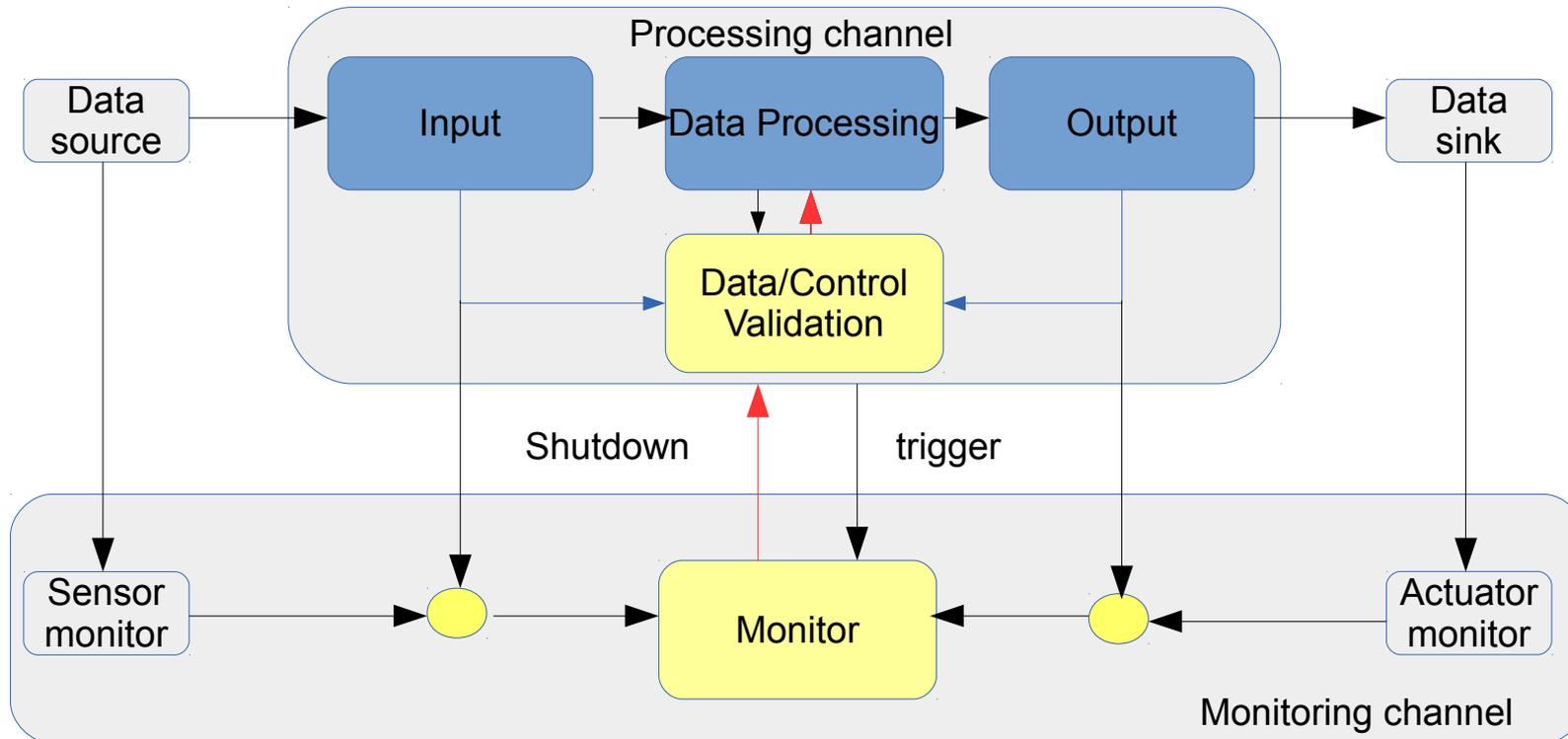


Source:  
Goble, Safety instrumented systems verification:  
practical probabilistic calculation



# 1oo1D

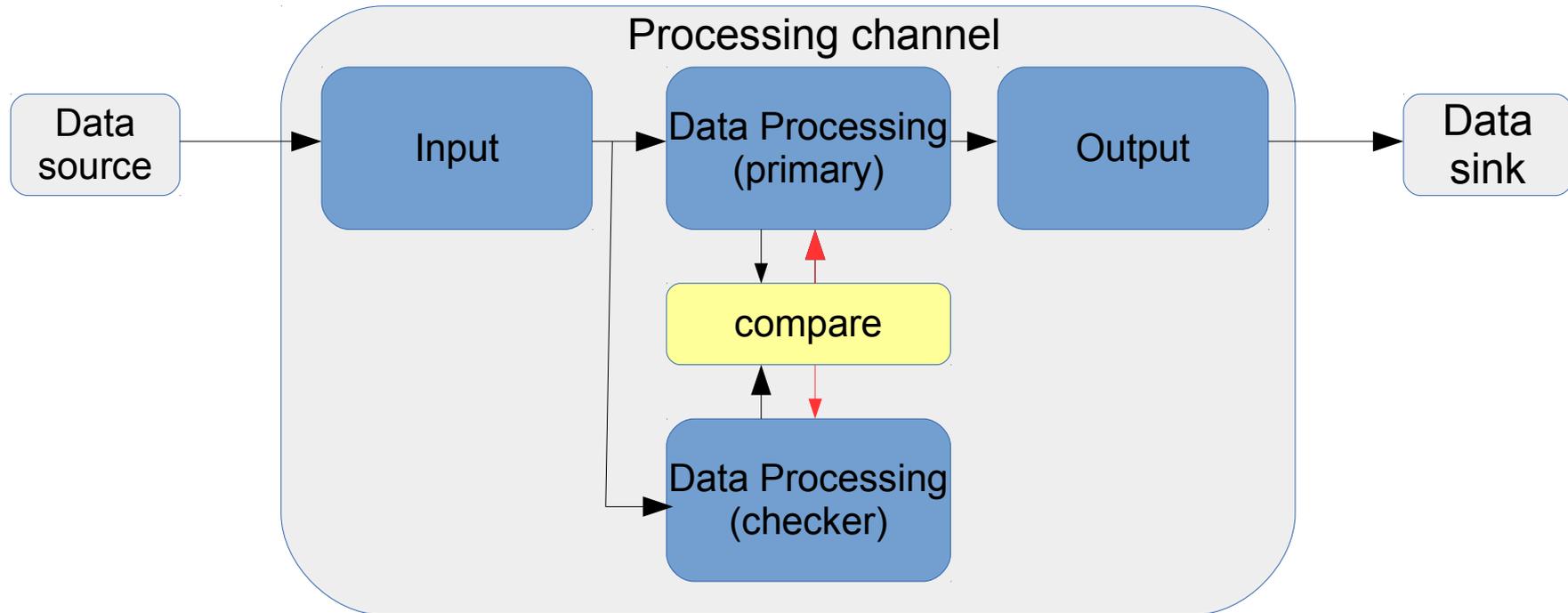
## - external monitor -



- Provides data and control flow checks (sanity checks and/or condition monitoring)
  - External watchdog, acceptance tests by limits, etc.
- Use: up to SIL2

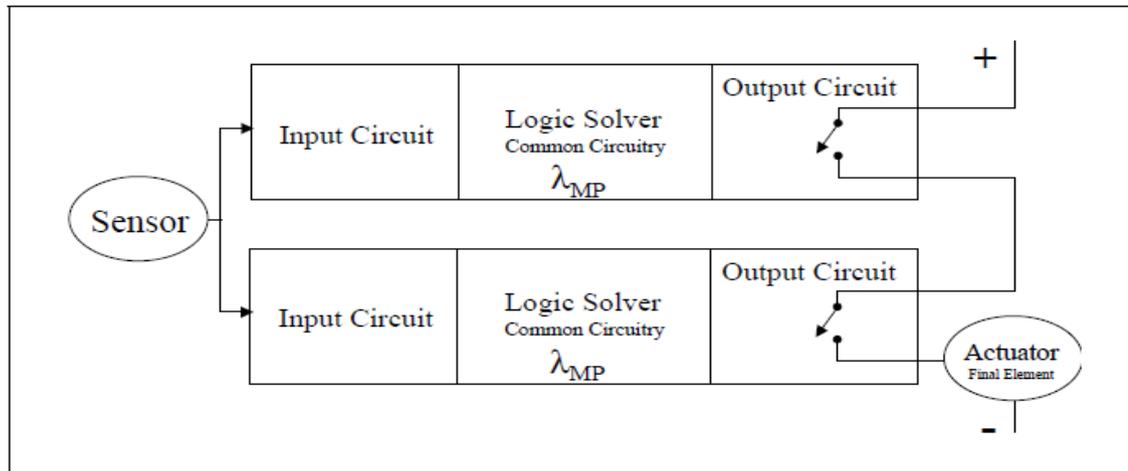
# 1oo1D

- lock-step -

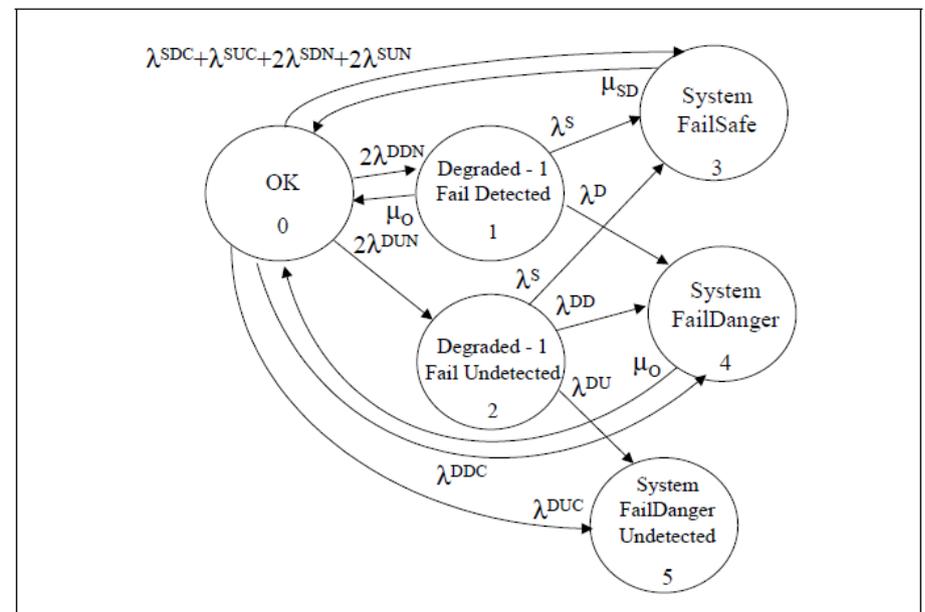
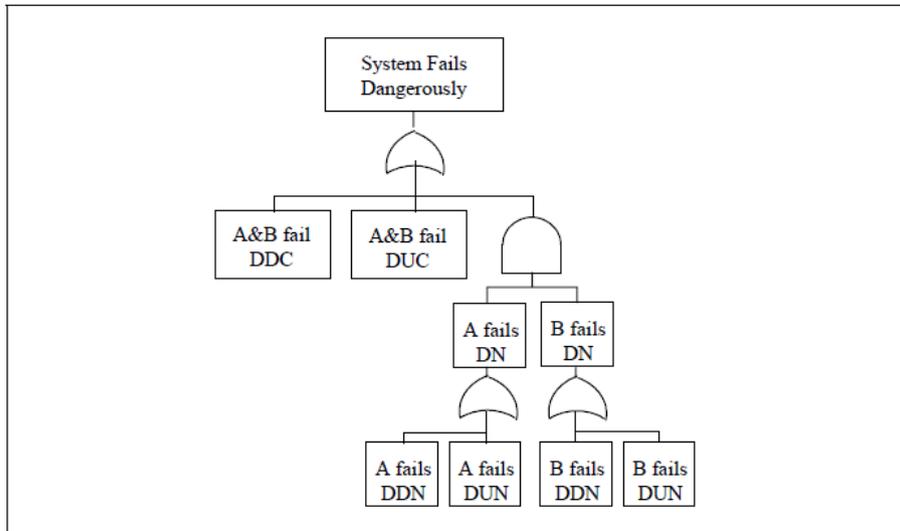


- Provides data and control flow checks in hardware (parallel execution with time shift, layout diversity)
- Use: up to SIL3

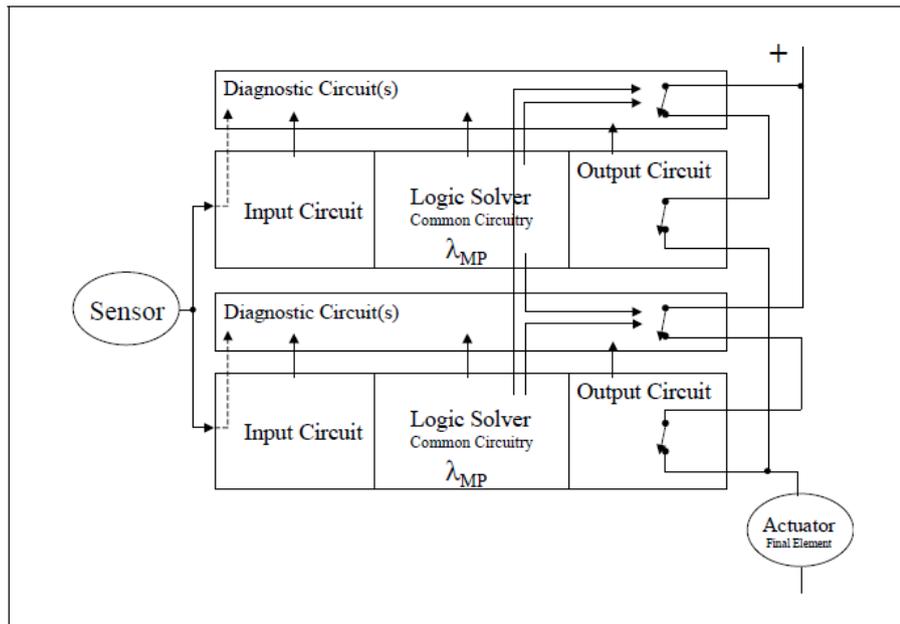
# Dual Channel - 1oo2 System



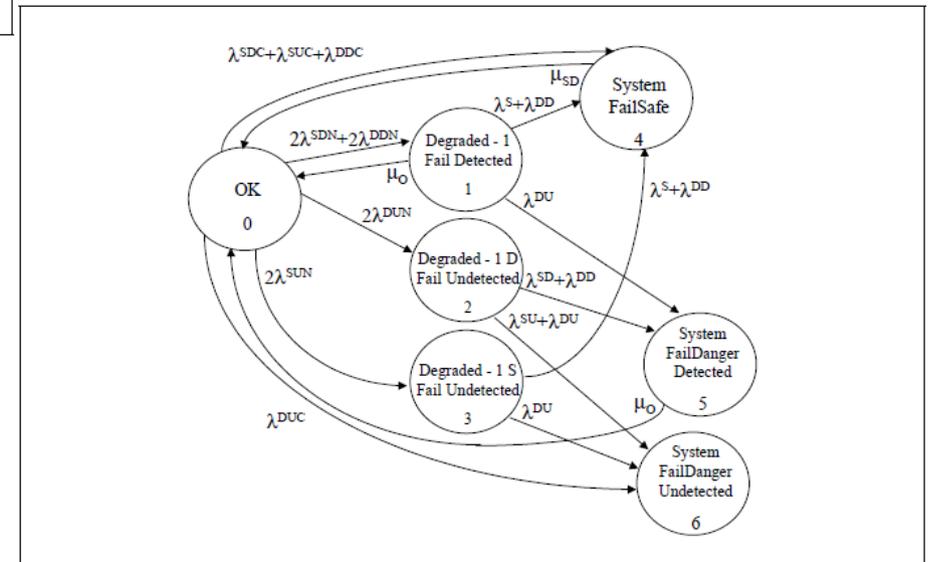
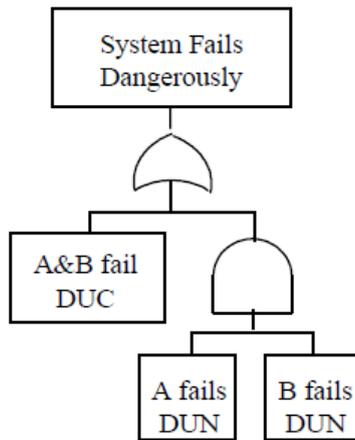
Source:  
Goble, Safety instrumented systems verification:  
practical probabilistic calculation



# Dual Channel - 1oo2D System

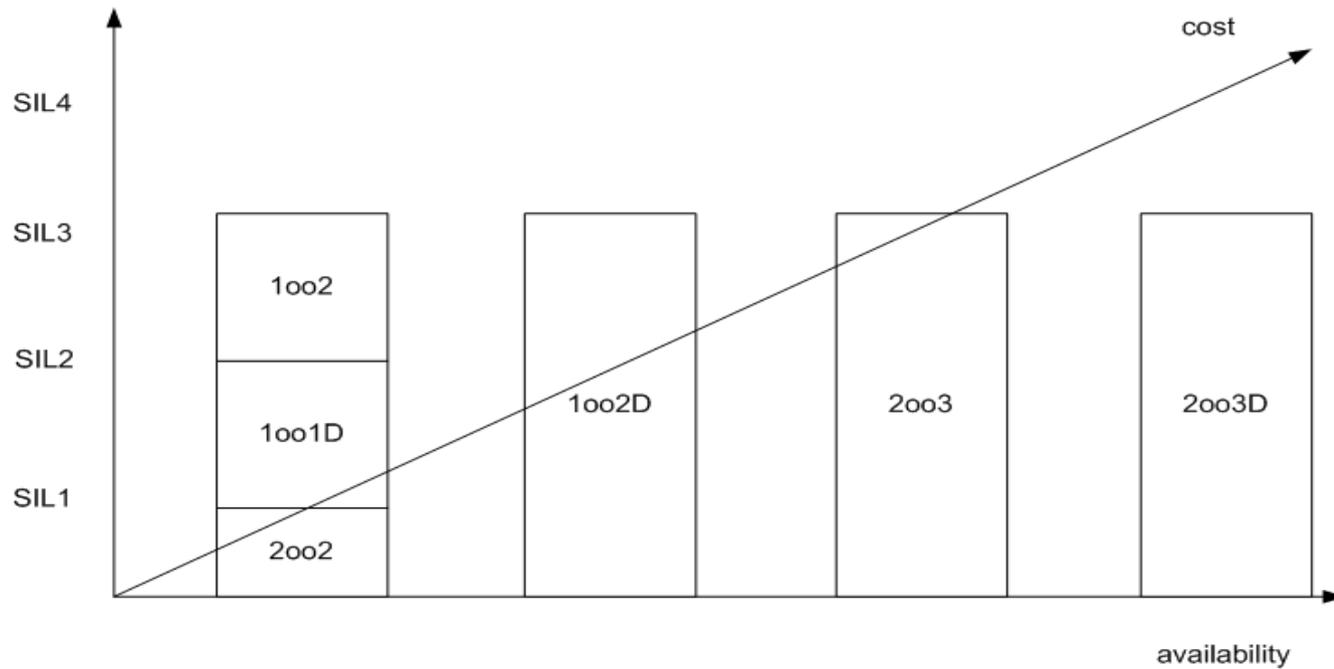


Source:  
Goble, Safety instrumented systems verification:  
practical probabilistic calculation





# Architectures and Cost



Architecture	Number of units	Output Switches	Objective
1oo1	1	1	Base unit
1oo2	2	2	High Safety
2oo2	2	2	Maintain output
1oo1D	1	2	High Safety
2oo3	3	6	Safety and Availability
2oo2D	2	4	Safety and Availability
1oo2D	2	4	Safety and Availability – biased toward Safety

Source:  
 Goble, Safety instrumented  
 systems verification:  
 practical probabilistic  
 calculation

# Systematic Failures

- Architecture: common cause failures, dependency failures
  - Freedom from interference
  - Look at common cause failures in previous Markov diagrams
- Software: SIL for software renamed to systematic capability (SC) in IEC61508 Edition 2.0
  - SC N supports a safety function of SIL N